

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/589,986	ARPAC ET AL.	
Examiner	Art Unit	
Mission Chan	1704	

SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
inventor search	11/22/2009	NC/		
EAST text search printout	11/22/2009	/VC/		